

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/781,862	FUJIMAKI, KAZUHIRO	
		Examiner	Art Unit	Page 1 of 1
		Sin J. Lee	1752	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0025489 A1	02-2002	Shimada et al.	430/270.1
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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**FOREIGN PATENT DOCUMENTS**

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